

捷多邦,专业PCB打样



1K Commercial

X2201A

1024 x 1 Bit

Nonvolatile Static RAM



FEATURES

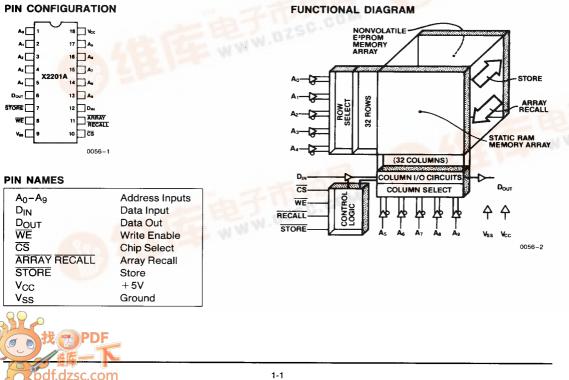
- Single 5V Supply
- Fully TTL Compatible
- Infinite E²PROM Array Recall, RAM Read and Write Cycles
- Access Time of 300 ns Max.
- Nonvolatile Store Inhibit: V_{CC} = 3V Typical
- High Reliability
 - -Store Cycles: 10,000
 - -Data Retention: 100 Years

DESCRIPTION

The Xicor X2201A is a 1024 x 1 NOVRAM featuring a high-speed static RAM overlaid bit-for-bit with a nonvolatile E²PROM. The X2201A is fabricated with the same reliable N-channel floating gate MOS technology used in all Xicor 5V nonvolatile memories.

The NOVRAM design allows data to be easily transferred from RAM to E²PROM (store) and from E²PROM to RAM (recall). The store operation is completed in 10 ms or less and the recall is typically completed in 1 µs.

Xicor NOVRAMs are designed for unlimited write operations to RAM, either from the host or recalls from E²PROM. The E²PROM array is designed for a minimum 10,000 store cycles and inherent data retention is specified to be greater than 100 years. Refer to RR-520 and RR-515 for details on Xicor nonvolatile memory endurance and data retention characteristics.



ABSOLUTE MAXIMUM RATINGS*

Temperature Under Bias	10°C to +85°C
Storage Temperature	65°C to +150°C
Voltage on any Pin with	
Respect to Ground	1.0V to +7V
D.C. Output Current	5 mA
Lead Temperature	
(Soldering, 10 Seconds)	

D.C. OPERATING CHARACTERISTICS

 $T_A = 0^{\circ}C$ to +70°C, $V_{CC} = +5V \pm 10\%$, unless otherwise specified.

*COMMENT

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and the functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Symbol	Parameter	Limits		Units	Test Conditions
	r aramotor	Min.	Max.	01110	
Icc	Power Supply Current		60	mA	All Inputs = V_{CC} $I_{I/O} = 0 \text{ mA}$
I _{LI}	Input Load Current		10	μΑ	$V_{IN} = GND$ to V_{CC}
LO	Output Leakage Current		10	μA	$V_{OUT} = GND to V_{CC}$
V _{IL} (2)	Input Low Voltage	- 1.0	0.8	V	
V _{IH} (2)	Input High Voltage	2.0	V _{CC} + 1.0	V	
VOL	Output Low Voltage		0.4	V	$I_{OL} = 4.2 \text{ mA}$
VOH	Output High Voltage	2.4		v	$I_{OH} = -2 mA$

ENDURANCE AND DATA RETENTION

Parameter	Min.	Units	Conditions
Endurance	1,000	Data Changes Per Bit	Xicor Reliability Reports RR-520 and RR-504
Store Cycles	10,000	Store Cycles	Xicor Reliability Reports RR-520 and RR-504
Data Retention	100	Years	Xicor Reliability Report RR-515

$\label{eq:capacitance} \textbf{CAPACITANCE} \quad \textbf{T}_{A} \,=\, 25^{\circ}\text{C}, \, \textbf{f} \,=\, 1.0 \,\, \text{MHz}, \, \textbf{V}_{CC} \,=\, 5\text{V}$

Symbol	Test	Max.	Units	Conditions
C _{I/O} (1)	Input/Output Capacitance	8	pF	$V_{I/O} = 0V$
C _{IN} ⁽¹⁾	Input Capacitance	6	pF	$V_{IN} = 0V$

Notes: (1) This parameter is periodically sampled and not 100% tested.

(2) $V_{\rm IL}$ min. and $V_{\rm IH}$ max. are for reference only and are not tested.

A.C. CONDITIONS OF TEST

Input Pulse Levels	0V to 3.0V
Input Rise and Fall Times	10 ns
Input and Output Timing Levels	1.5V
Output Load	1 TTL Gate and $C_L = 100 \text{ pF}$

MODE SELECTION

	Inputs			Input Output	Mode
CS	WE	ARRAY RECALL	STORE	1/0	Mode
н	x	Н	н	Output High Z	Not Selected ⁽³⁾
L	н	Н	н	Output Data	Read RAM
L	L	Н	н	Input Data High	Write "1" RAM
L	L	Н	Н	Input Data Low	Write "0" RAM
х	н	L	Н	Output High Z	Array Recall
н	Х	L	н	Output High Z	Array Recali
X	н	Н	L	Output High Z	Nonvolatile Storing ⁽⁴⁾
н	x	Н	L	Output High Z	Nonvolatile Storing ⁽⁴⁾

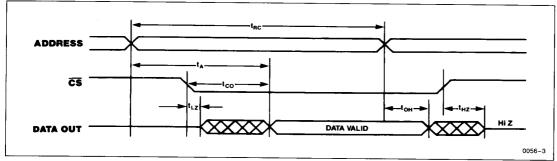
A.C. CHARACTERISTICS

 T_{A} = 0°C to +70°C, V_{CC} = +5V \pm 10%, unless otherwise specified.

Read Cycle Limits

Symbol	Parameter	Min.	Max.	Units
t _{RC}	Read Cycle Time	300		ns
t _A	Access Time		300	ns
tco	Chip Select to Output Valid		200	ns
t _{OH}	Output Hold from Address Change	50		ns
t _{LZ} (5)	Chip Select to Output in Low Z	10		ns
t _{HZ} (5)	Chip Deselect to Output in High Z	10	100	ns

Read Cycle



Notes: (3) Chip is deselected but may be automatically completing a store cycle.

(4) $\overline{\text{STORE}} = L$ is required only to initiate the store cycle, after which the store cycle will be automatically completed (STORE = X).

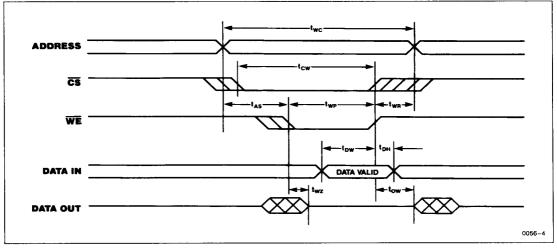
(5) t_{LZ} min. and t_{HZ} min. are periodically sampled and not 100% tested.

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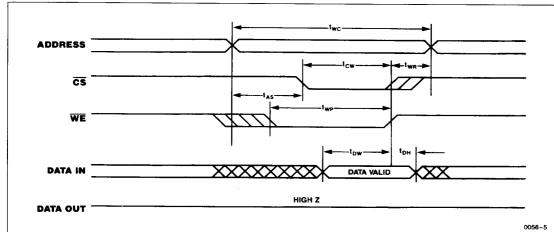
Write Cycle Limits

Symbol	Parameter	Min.	Max.	Units
twc	Write Cycle Time	300		ns
tcw	Chip Select to End of Write	150		ns
t _{AS}	Address Setup Time	50		ns
twp	Write Pulse Width	150		ns
twn	Write Recovery Time	25		ns
t _{DW}	Data Valid to End of Write	100		ns
t _{DH}	Data Hold Time	0		ns
twz	Write Enable to Output in High Z	10	100	ns
tow	Output Active from End of Write	10		ns

Write Cycle



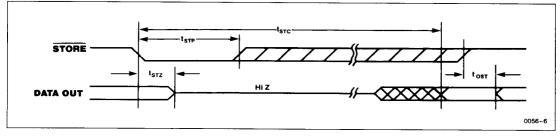
Early Write Cycle



Store Cycle Limits

Symbol	Parameter	Min.	Max.	Units
tstc	Store Time		10	ms
tSTP	Store Pulse Width	100		ns
t _{STZ}	Store to Output in High Z		500	ns
t _{OST}	Output Active from End of Store	10		ns

Store Cycle

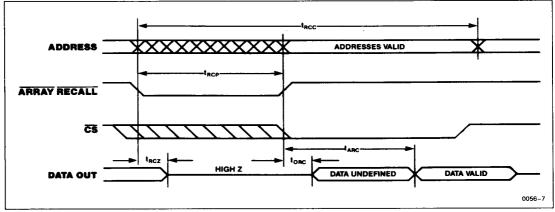


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Array Recall Cycle Limits

Symbol	Parameter	Min.	Max.	Units
tRCC	Array Recall Cycle Time	1200		ns
tRCP	Recall Pulse Width ⁽⁶⁾	450		ns
t _{RCZ}	Recall to Output in High Z		150	ns
tORC	Output Active from End of Recall	10		ns
tARC	Recalled Data Access Time from End of Recall		750	ns

Array Recall Cycle



Note: (6) Array Recall rise time must be less than 1 µs.

PIN DESCRIPTIONS AND DEVICE OPERATION

Addresses (A₀-A₉)

The address inputs select a memory location during a read or write operation.

Chip Select (CS)

The Chip Select input must be LOW to enable read/ write operations with the RAM array. \overline{CS} HIGH will place the D_{OUT} in the high impedance state.

Write Enable (WE)

The Write Enable input controls the D_{OUT} buffer, determining whether a RAM read or write operation is enabled. WE HIGH enables a read and WE LOW enables a write.

Data In (DIN)

Data is written into the device via the DIN input.

Data Out (DOUT)

Data from a selected address is output on the D_{OUT} output. This pin is in the high impedance state when either \overline{CS} is HIGH or when \overline{WE} is LOW.

STORE

The STORE input, when LOW, will initiate the transfer of the entire contents of the RAM array to the E²PROM array. The WE and ARRAY RECALL inputs are inhibited during the store cycle. The store operation will be completed in 10 ms or less.

A store operation has priority over RAM read/write operations. If STORE is asserted during a read operation, the read will be discontinued. If STORE is asserted during a RAM write operation, the write will be immediately terminated and the store performed. The data at the RAM address that was being written will be unknown in both the RAM and E²PROM.

ARRAY RECALL

The $\overline{\text{ARRAY}}$ RECALL input, when LOW, will initiate the transfer of the entire contents of the E²PROM array to the RAM array. The transfer of data will typically be completed in 1 μ s or less.

An array recall has priority over RAM read/write operations and will terminate both operations when ARRAY RECALL is asserted. ARRAY RECALL LOW will also inhibit the STORE input.

WRITE PROTECTION

The X2201A has three write protect features that are employed to protect the contents of the nonvolatile memory.

- V_{CC} Sense—All functions are inhibited when V_{CC} is \leq 3V, typically.
- Write Inhibit—Holding either STORE HIGH or ARRAY RECALL LOW during power-up or power-down will prevent an inadvertent store operation and E²PROM data integrity will be maintained. It should be noted; whichever method is employed, all control inputs should be stable and the device deselected prior to release of the controlling protection signal.
- Noise Protection—A STORE pulse of less than 20 ns (typical) will *not* initiate a store cycle.

Part Number	Store Cycles	Data Changes Per Bit
X2201A	10,000	1,000

SYMBOL TABLE

WAVEFORM	INPUTS Must be steady	OUTPUTS Will be steady
	May change from Low to High	Will change from Low to High
	May change from High to Low	Will change from High to Low
XXXXX	Don't Care: Changes Allowed	Changing : State Not Known
	N/A	Center Line is High Impedance

